

<b>Notice of References Cited</b>	Application/Control No. 09/040,560	Applicant(s)/Patent Under Reexamination SHINOTSUKA, HIDEAKI	
	Examiner Hai Tran	Art Unit 2611	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5420573	05-1995	Tanaka et al.	340/825.24
	B	US-5838248	11-1998	Nagano	340/2.7
	C	US-5265241	11-1993	Arnold et al.	710/15
	D	US-5754548	05-1998	Hoekstra et al.	370/402
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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